8/16-bit Data Bus Static RAM Card

MF365A-LYCATXX
MF3129-LYCATXX
MF3257-LYCATXX
MF3513-LYCATXX
MF31M1-LYCATXX
MF32M1-LYCATXX
MF34M1-LYCATXX

Connector Type

Two- piece 68-pin

1. DESCRIPTION

Mitsubishi's Static RAM cards provide large memory capacities on a device approximately the size of a credit card (85.6mm×54mm×3.3mm). The cards use a 8/16 bit data-bus.
Available in 64KB, 128KB, 256KB, 512KB, 1 MB, 2 MB and 4 MB capacities, Mitsubishi's SRAM cards conform to the PC Card Standard. Mitsubishi achieved high density memory, while maintaining credit size by using a thin small outline packaging technology (TSOP). The TSOP surpasses conventional memory card chip-on-board packaging technology where larger, surface-mount devices result in a tradeoff between card size and optimum memory density. The TSOP, with external leads spaced on 20-mil centers, is over four times smaller than standard equivalent pin count surface-mount packages. This allows up to 8 memory ICs (plus interface circuitry) to be mounted in a card that in only 3.3mm thick.

2. FEATURES

- ■Uses TSOP (Thin Small Outline Package) to achieve very high memory density coupled with high reliability, without enlarging card size
- ■Electrostatic discharge protection to 15kV
- ■Buffered interface
- ■Write protect switch
- ■68pin

3. APPLICATIONS

- ■Office automation
- ■Data Communication
- ■Computers
- ■Industrial
- ■Telecommunications
- ■Consumer

4. PRODUCT LIST

Item / Type name	Memory capacity	Data Bus width(bits)	Attribute memory	Auxiliary battery
MF365A-LYCATXX	64KB	8/16	NO	NO
MF3129-LYCATXX	128KB			
MF3257-LYCATXX	256KB			
MF3513-LYCATXX	512KB			
MF31M1-LYCATXX	1MB			
MF32M1-LYCATXX	2MB			
MF34M1-LYCATXX	4MB			

5. SUMMARY

MF3XXX-LYCATXX series is the Static RAM cards which has 8/16 bit changeable data-bus width. The card has a replaceable lithium battery to maintain data in memory. When the card is not use or the supply voltage drops, the battery will automatically maintain data in memory.

6. FUNCTIONAL DESCRIPTION

The function of the card is determined by the combination of the following five control signals, REG#, CE1#, CE2#, OE#, WE#; active low signals. (Please refer to section 10 FUNCTION TABLE on page 5)

(1)COMMON MEMORY FUNCTION

When REG# signal is high level, the common memory area is selected.

(a)READ MODE

To read, WE# is set high level and CE1# or CE2# is set low level and the memory address is applied at inputs A0-A21(4MB). Setting OE# low level executes the reading with output at data-bus. It is available to make the following functions according to the combination of CE1# and CE2#.

When CE1# is set low level and CE2# is set high level, the card operates as an 8 bit data-bus width card. The data can be dealt with lower data-bus(D0-D7).

When both CE1# and CE2# are set low level, the card operates as a 16 bit data-bus width card. At this mode LSB of address-bus (A0) is ignored.

In addition odd byte can be accessed through upper data-bus(D8-D15) when CE1# is set high level and CE2# is set low level. This mode is useful when handling only odd bytes in the 16 bit data-bus interface system (A0 is ignored).

When both CE1# and CE2# are set high level, the card becomes a standby mode where the card consumes low power and the data-bus is placed in high impedance state (above functions of CE1# and CE2# are the same as in the following modes).

When both OE# and WE# are set high level, the card becomes a output disable mode and the data-bus is placed in high impedance state.

(b)WRITE MODE

To write, the memory address is first applied at inputs A0-A21(4MB) and the data is applied at output pins. Setting CE1# or CE2# low level, WE# low level and OE# high level executes the writing.

(2)ATTRIBUTE MEMORY FUNCTION

When REG# is set low level, the attribute memory area is selected. MF3XXX-LYCATXX series have no attribute memory, but outputs FFh on the lower data-bus(D0-D7) when the following conditions are applied

(a)setting CE1# low, CE2# high, OE# low, WE# high and A0 low

(b)setting CE1# low, CE2# low, OE# low and WE# high

7. WRITE PROTECT MODE

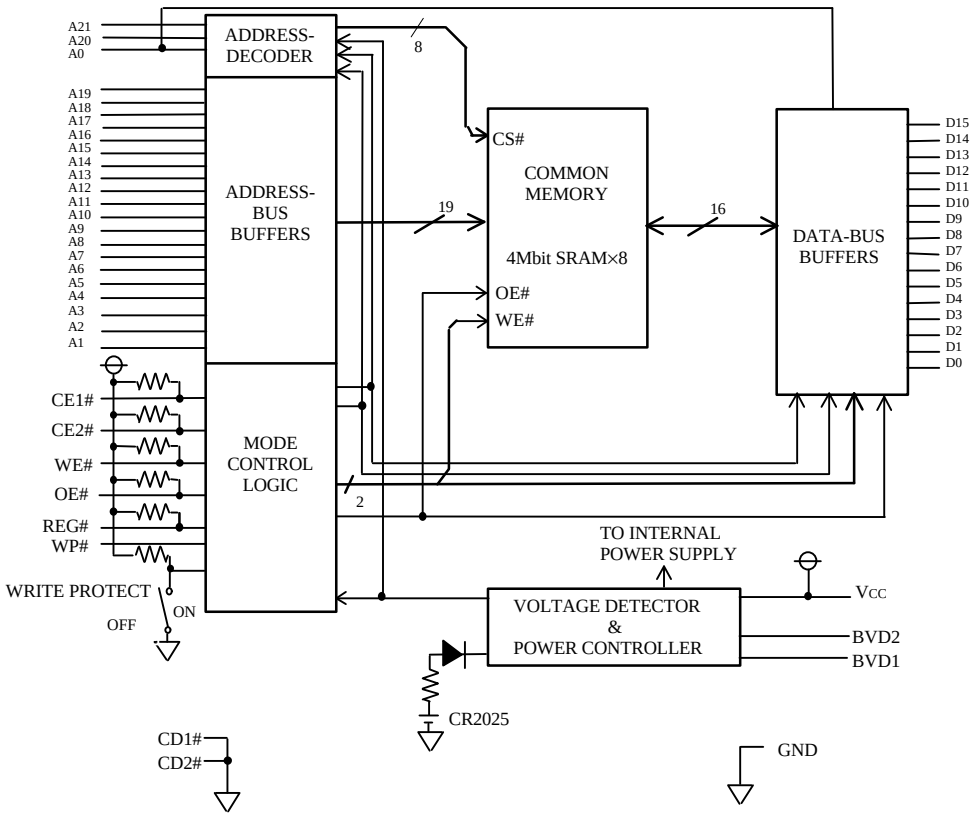
When the write protect switch is switched on, this card goes into a write protect mode that can read but not write data. In this mode, WP pin becomes “H” level.

At the shipment the write protect switch is switched off (Normal mode : The card can be written ; WP pin indicates “L” level).

8. PIN ASSIGNMENTS

Pin No.	Symbol	Function	Pin No.	Symbol	Function
1	GND	Ground	35	GND	Ground
2	D3	Data I/O	36	CD1#	Card detect 1
3	D4		37	D11	Data I/O
4	D5		38	D12	
5	D6		39	D13	
6	D7		40	D14	
7	CE1#	Card enable 1	41	D15	
8	A10	Address input	42	CE2#	Card enable 2
9	OE#	Output enable	43	NC	No connection
10	A11	Address input	44	NC	
11	A9		45	NC	
12	A8		46	A17	A17 (NC for ≤ 128KB types)
13	A13		47	A18	A18 (NC for ≤ 256KB types)
14	A14		48	A19	A19 (NC for ≤ 512KB types)
15	WE#	Write enable	49	A20	A20 (NC for ≤ 1MB type)
16	NC	No connection	50	A21	A21 (NC for ≤ 2MB type)
17	VCC	Power supply voltage	51	VCC	Power supply voltage
18	NC	No connection	52	NC	No connection
19	A16	A16 (NC for 64KB type)	53	NC	
20	A15	Address input	54	NC	
21	A12		55	NC	
22	A7		56	NC	
23	A6		57	NC	
24	A5		58	NC	
25	A4		59	NC	
26	A3		60	NC	
27	A2		61	REG#	Attribute memory select
28	A1		62	BVD2	Battery voltage detect 2
29	A0		63	BVD1	Battery voltage detect 1
30	D0	Data I/O	64	D8	Data I/O
31	D1		65	D9	
32	D2		66	D10	
33	WP	Write protect	67	CD2#	Card detect 2
34	GND	Ground	68	GND	Ground

9. BLOCK DIAGRAM (4MB) (MF34M1-LYCATXX)



10. FUNCTION TABLE

Mode	REG#	CE1#	CE2#	OE#	WE#	A0	I/O (D15~D8)	I/O (D7~D0)	Icc
Standby	X	H	H	X	X	X	High-impedance	High-impedance	standby
Read A (16bit) common	H	L	L	L	H	X	Odd Byte Data out	Even Byte Data out	Active
Write A (16bit) common	H	L	L	H	L	X	Odd Byte Data in	Even Byte Data in	Active
Read B (8bit) common	H	L	H	L	H	L	High-impedance	Even Byte Data out	Active
	H	L	H	L	H	H	High-impedance	Odd Byte Data out	Active
Write B (8bit) common	H	L	H	H	L	L	High-impedance	Even Byte Data in	Active
	H	L	H	H	L	H	High-impedance	Odd Byte Data in	Active
Read C (8bit) common	H	H	L	L	H	X	Odd Byte Data out	High-impedance	Active
Write C (8bit) common	H	H	L	H	L	X	Odd Byte Data in	High-impedance	Active
Output disable	X	X	X	H	H	X	High-impedance	High-impedance	Active
Read A (16bit) attribute	L	L	L	L	H	X	Data out (unknown)	Data out (FFh)	Active
Read B (8bit) attribute	L	L	H	L	H	L	High-impedance	Data out (FFh)	Active
	L	L	H	L	H	H	High-impedance	Data out (unknown)	Active
Read C (8bit) attribute	L	H	L	L	H	X	Data out (unknown)	High-impedance	Active

Note 1 : H=V_{IH}, L=V_{IL}, X=V_{IH} or V_{IL}

11. ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Unit
Vcc	Supply voltage	With respect to GND	-0.3~6.0	V
V_I	Input voltage		-0.3~Vcc+0.3	V
V_O	Output voltage		0~Vcc	V
Topr1	Operating temperature 1	Read, Write Operation	0~60	°C
Topr2	Operating temperature 2	Data retention	0~60	°C
Tstg	Storage temperature	Excludes data retention	-20~70	°C

12. RECOMMENDED OPERATING CONDITIONS (Ta=0~55°C, unless otherwise noted)

Symbol	Parameter	Limits			Unit
		Min.	Typ.	Max.	
Vcc	Vcc Supply voltage	4.50	5.0	5.25	V
GND	System ground		0		V
V_{IH}	High input voltage	3.5		Vcc	V
V_{IL}	Low input voltage	0		0.8	V

13. ELECTRICAL CHARACTERISTICS (Ta=0~55°C, Vcc=4.50~5.25V, unless otherwise noted)

Symbol	Parameter	Test conditions			Limits			Unit
					Min.	Typ.	Max.	
V_{OH}	High output voltage	I_{OH}= -1.0mA			2.4			V
V_{OL}	Low output voltage	I_{OL}=2mA					0.4	V
I_{IH}	High input current	V_I=Vcc V					10	µA
I_{IL}	Low input current	V_I=0V	CE1#, CE2#, WE#, OE#, REG#		-10		-70	µA
			Other inputs				-10	
I_{OZH}	High output current in off state	CE1#=CE2#=V_{IH} or OE#=V_{IH} WE#=V_{IH}, V_O=Vcc					10	µA
I_{OZL}	Low output current in off state	CE1#=CE2#=V_{IH} or OE#=V_{IH} WE#=V_{IH}, V_O=0V					-10	µA
Icc 1 • 1	Active supply current 1	CE1#=CE2#=V_{IL}, Other inputs= V_{IH} or V_{IL} Outputs=open	64KB~512KB	16bit			170	mA
				8bit			115	
			1MB~4MB	16bit			230	
				8bit			155	
Icc 1 • 2	Active supply current 2	CE1#=CE2# ≤ 0.2V Other inputs ≤ 0.2V or ≥ Vcc-0.2V Outputs=open	64KB~512KB	16bit			160	mA
				8bit			110	
			1MB~4MB	16bit			220	
				8bit			150	
Icc 2 • 1	Standby supply current 1	CE1#=CE2#=V_{IH} Other inputs=V_{IH} or V_{IL}	64KB~4MB				10	mA
Icc 2 • 2	Standby supply current 2	CE1#=CE2# ≥ Vcc-0.2V Other inputs ≤ 0.2V or ≥ Vcc-0.2V	64KB~512KB			0.15	0.45	mA
			1MB~4MB			0.30	0.65	
VBDET1	Battery detect reference voltage	Vcc=5V, Ta=25°C			2.27	2.37	2.47	V
VBDET2	Battery detect reference voltage	Vcc=5V, Ta=25°C			2.55	2.65	2.75	V

Note 2 : Currents flowing into the card are taken as positive (unsigned).
3 : Typical values are measured at Vcc=5V, Ta=25°C.

14. CAPACITANCE

Symbol	Parameter	Test conditions	Limits			Unit
			Min.	Typ.	Max.	
C_I	Input capacitance	V_I=GND, v_i=25mVrms f=1MHz, Ta=25°C			30	pF
C_O	Output Capacitance	Vo=GND, vo=25mVrms f=1MHz, Ta=25°C			20	pF

Note 4 : These parameters are not 100% tested.

15. SWITCHING CHARACTERISTICS

Read Cycle (Ta=0~55°C, Vcc=4.5~5.25V, unless otherwise noted)

Symbol	Parameter	Limits		Unit
		Min.	Max.	
tcR	Read cycle time	150		ns
t_a(A)	Address access time		150	ns
t_a(CE)	Card enable access time		150	ns
t_a(OE)	Output enable access time		75	ns
t_{dis}(CE)	Output disable time (from CE#)		75	ns
t_{dis}(OE)	Output disable time (from OE#)		75	ns
t_{en}(CE)	Output enable time (from CE#)	5		ns
t_{en}(OE)	Output enable time (from OE#)	5		ns
t_V(A)	Data valid time (after address change)	0		ns

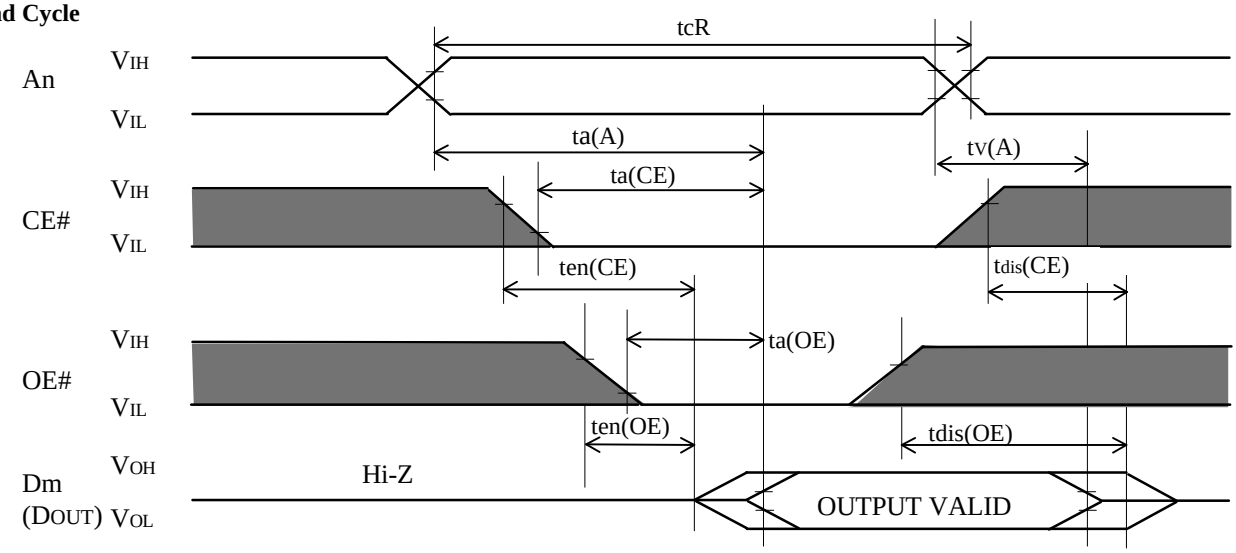
16. TIMING REQUIREMENTS

Write Cycle (Ta=0~55°C, Vcc=4.5~5.25V, unless otherwise noted)

Symbol	Parameter	Limits		Unit
		Min.	Max.	
tcW	Write cycle time	150		ns
tw(WE)	Write pulse width	80		ns
tsu(A)	Address set up time	20		ns
tsu(A-WEH)	Address set up time with respect to WE# high	100		ns
tsu(CE-WEH)	Card enable set up time with respect to WE# high	100		ns
t(D-WEH)	Data set up time with respect to WE# high	50		ns
th(D)	Data hold time	20		ns
trec(WE)	Write recovery time	20		ns
tdis(WE)	Output disable time (from WE#)		75	ns
tdis(OE)	Output disable time (from OE#)		75	ns
ten(WE)	Output enable time (from WE#)	5		ns
ten(OE)	Output enable time (from OE#)	5		ns
tsu(OE-WE)	OE# set up time with respect to WE# low	10		ns
th(OE-WE)	OE# hold time with respect to WE# high	10		ns

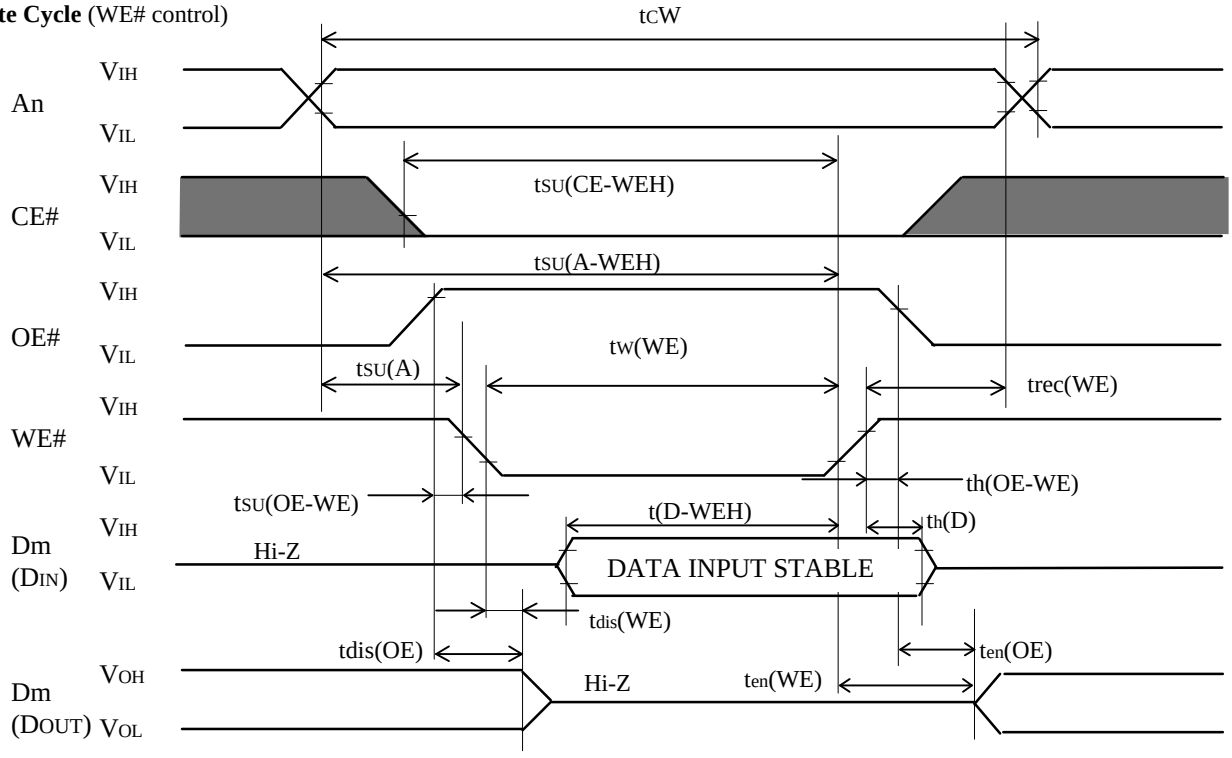
TIMING DIAGRAM

Read Cycle



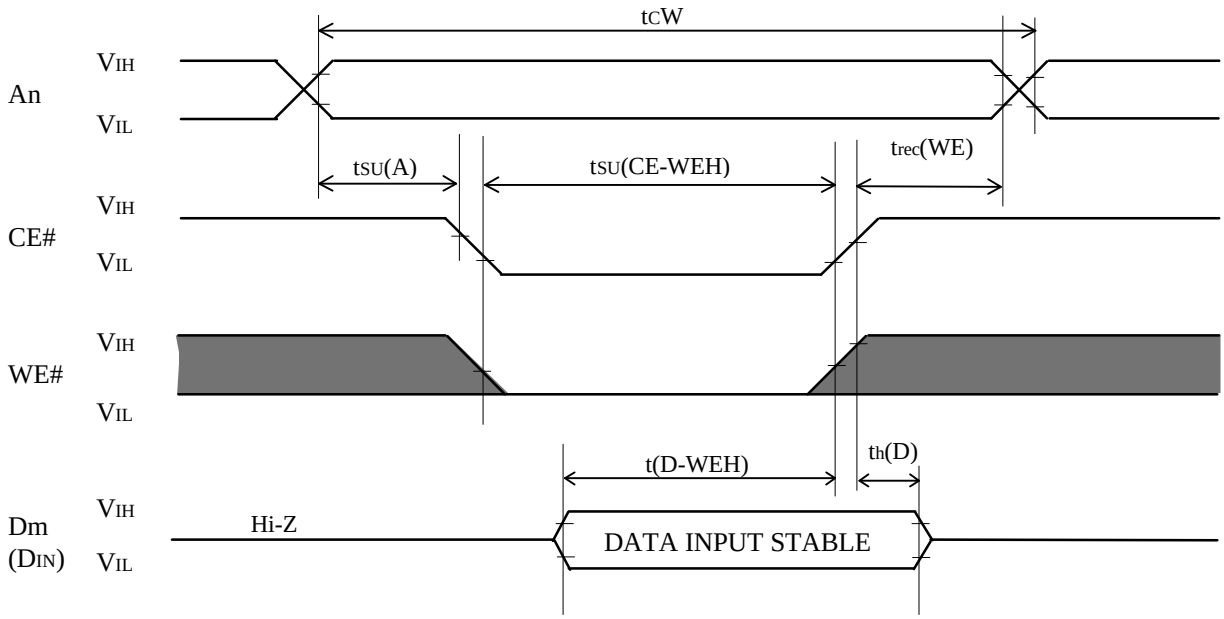
WE#="H" level
REG#="H" level

Write Cycle (WE# control)



REG#="H" level

Write Cycle (CE# control)



OE#="H" level
REG#="H" level

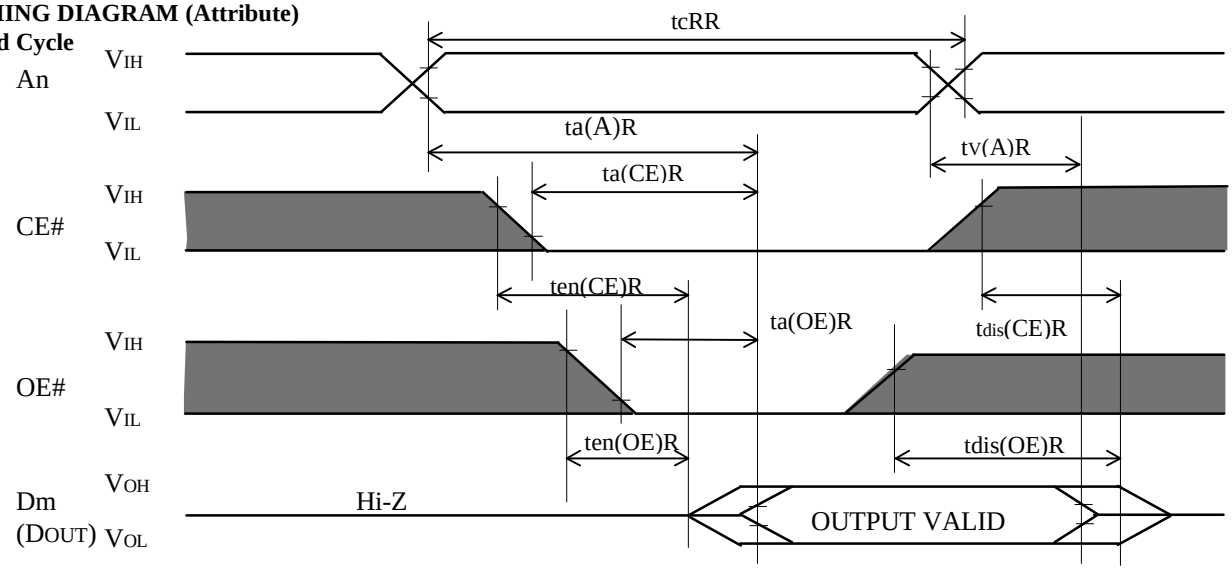
17. SWITCHING CHARACTERISTICS (Attribute)

Read Cycle (Ta=0~55°C, Vcc=4.5~5.25V, unless otherwise noted)

Symbol	Parameter	Limits		Unit
		Min.	Max.	
tcRR	Read cycle time	300		ns
ta(A)R	Address access time		300	ns
ta(CE)R	Card enable access time		300	ns
ta(OE)R	Output enable access time		150	ns
tdis(CE)R	Output disable time (from CE#)		100	ns
tdis(OE)R	Output disable time (from OE#)		100	ns
ten(CE)R	Output enable time (from CE#)	5		ns
ten(OE)R	Output enable time (from OE#)	5		ns
tV(A)R	Data valid time after address change	0		ns

TIMING DIAGRAM (Attribute)

Read Cycle



WE#="H" level
REG#="L" level

Note 5 : Test Conditions

Input pulse levels : V_{IL}=0.4V, V_{IH}=4.0V

Input pulse rise, fall time : tr=tf=10ns

Reference voltage

Input : V_{IL}=0.8V, V_{IH}=3.5V

Output : V_{OL}=0.8V, V_{OH}=3.0V

(ten and tdis are measured when output voltage is ± 500mV from steady state.)

Load : 100pF + 1 TTL gate

5pF + 1 TTL gate (at ten and tdis measuring)

6 : ▬▬ Indicates the don't care input

7 : Writing is executed in overlap of CE# and WE# are "L" level. (only for Common Memory)

8 : Don't apply inverted phase signal externally when Dm pin is in output mode.

9 : CE# is indicated as follows:

Read A/Write A : CE#=CE1#=CE2#

Read B/Write B : CE#=CE1#, CE2#="H" level

Read C/Write C : CE#=CE2#, CE1#="H" level

18. ELECTRICAL CHARACTERISTICS

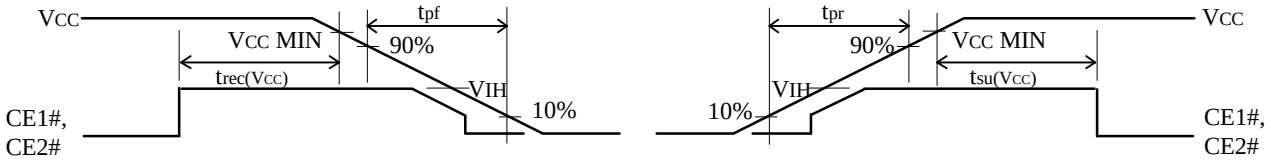
BATTERY BACKUP (Ta=0~55°C, unless otherwise noted)

Symbol	Parameter	Test conditions		Limits			Unit
				Min.	Typ.	Max.	
V_{BATT}	Back-up enable battery voltage	All pins open		2.6			V
Vi(CE)	Card enable voltage	3.5V≤VCC≤5.25V		3.5			V
		0V≤VCC<3.5V		Vcc-0.1	Vcc	Vcc+0.1	
Icc (Bup)	Battery back-up supply current	All pins open, V_{BATT}=3V, Ta=25°C	64KB			3	µA
			128KB			3	
			256KB			3	
			512KB			5	
			1MB			3	
			2MB			5	
			4MB			9	
	Battery back-up supply current	All pins open, V_{BATT}=3V	64KB			30	µA
			128KB			30	
			256KB			30	
			512KB			50	
			1MB			30	
			2MB			50	
			4MB			90	

19. TIMING REQUIREMENTS (Ta=0~55°C, unless otherwise noted)

Symbol	Parameter	Limits			
		Min.	Typ.	Max.	
Tpr	Power supply rise time	0.1		300	ms
tpf	Power supply fall time	3		300	ms
tsu(Vcc)	Setup time at power on	20			ms
trec(Vcc)	Recovery time at power off	1000			ns

CARD INSERTION/REMOVAL TIMING DIAGRAM



20.BATTERY SPECIFICATIONS

Please use the following coin type lithium battery.

Type of main battery; CR2025 or equivalents

20.1 BATTERY LIFE EXPECTANCY

The calculated main battery's life expectancies are as follows.

Card Type	main battery's life (when the card is left continuously)
MF365A-LYCATXX	5.9years
MF3129-LYCATXX	5.9years
MF3257-LYCATXX	5.9years
MF3513-LYCATXX	3.6years
MF31M1-LYCATXX	5.9years
MF32M1-LYCATXX	3.6years
MF34M1-LYCATXX	2.0years

Conditions; Temperature : 25°C Humidity : 60%RH

21. CONNECTOR

The number of card insertion and removal are as follows.

Office environment 10000 times min. at speed of 10 cycles/min.

Harsh environment 5000 times min. at speed of 10 cycles/min.

22. CARD WEIGHT about 30g

23. UL CLASS OF MAIN CARD PARTS

(1)MAIN FRAME UL94V-0

(2)PCB UL94V-0

(3)PLASTIC PART OF CONNECTOR UL94V-0

24. THE BATTERY VOLTAGE DETECT SIGNALS (BVD1,2)

BVD1	BVD2	Comment
H	H	Battery operational
H	L	Battery operational, but battery should be replaced
L	L	Battery and data integrity is not kept

Note10. The battery voltage detect signals indicate the present state of the battery. They do not guarantee the data retention.

25.CONCERNING THE SECURITY OF DATA

There is always the possibility that a soft-error (this malfunction is not permanent hence it is called soft and the data can be restored by rewriting) may occur with semiconductor products.

When keeping the important data within an IC card, remember to give due consideration to safety when making your circuit designs, with appropriate measures such as

(1) Keeping multiple copies of the data.

(2) Addition of ECC or CRC by software or hardware.

⚠ Warning (if card with battery / card with auxiliary battery)

(1)Do not charge, short, disassemble, deform, heat, or throw the batteries into fire, as they may ignite, overheat, rupture or explode.
(2)Place the batteries out of the reach of children. If somebody swallows them, they should see a doctor immediately.
(3)When discarding or storing the batteries, wrap them individually with cellophane tape or other nonconductive material. If they are positioned in contact with any other metals or batteries, they may explode, rupture or leak electrolyte solution.

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